

MSP430F665x、MSP430F645x、MSP430F565x、MSP430F535x 混合信号微控制器

1 特性

- 低电源电压范围：
3.6V 低至 1.8V
- 超低功耗
 - 激活模式 (AM)：
 - 所有系统时钟激活：
 - 8MHz 时为 295 μ A/MHz、3.0V、闪存程序执行 (典型值)
 - 待机模式 (LPM3)：
 - 含晶体的看门狗和电源监控器可用、完全 RAM 保持、快速唤醒：
 - 2.2V 时为 2.0 μ A，3.0V 时为 2.2 μ A (典型值)
 - 关断、实时时钟 (RTC) 模式 (LPM3.5)：
 - 关断模式，含晶体的有源 RTC：
 - 3.0V 时为 1.1 μ A (典型值)
 - 关断模式 (LPM4.5)：
 - 3.0V 时为 0.45 μ A (典型值)
- 在 3 μ s (典型值) 内从待机模式唤醒
- 16 位 RISC 架构，扩展存储器，高达 20MHz 的系统时钟
- 灵活的电源管理系统
 - 具有可编程稳压内核电源电压的完全集成 LDO
 - 电源电压监控、监视和欠压保护
- 单一时钟系统
 -

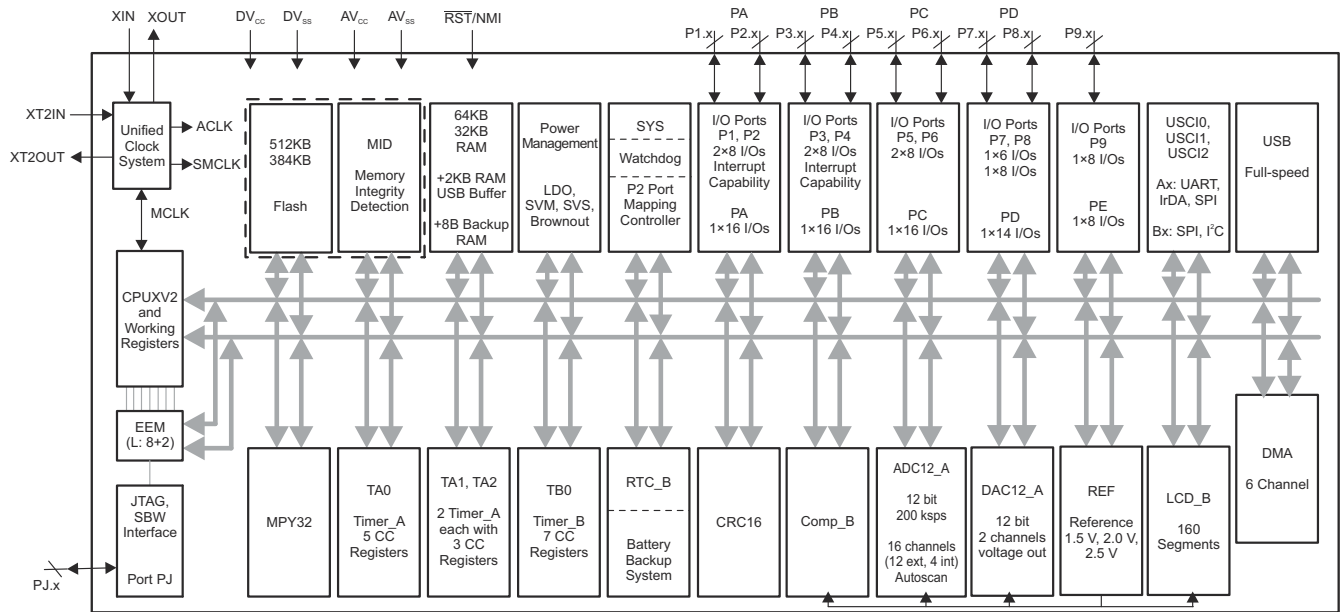
器件信息

器件型号 ⁽¹⁾	封装	封装尺寸 ⁽²⁾
MSP430F6659IPZ	LQFP (100)	14mm x 14mm
MSP430F6659IZCA	nFBGA (113)	7mm x 7mm
MSP430F6659IZQW ⁽³⁾	MicroStar Junior™ BGA (113)	7mm x 7mm

- (1) 要获得最新的器件、封装和订购信息，请参阅**封装选项附录**（[节 11](#)），或者访问 TI 网站 www.ti.com.cn。
- (2) 这里显示的尺寸为近似值。要获得包含误差值的封装尺寸，请参阅**机械数据**（[节 11](#) 中）。
- (3) 采用 ZQW (MicroStar Junior BGA) 封装的所有可订购器件型号均已更改为最晚可采购期限的状态。有关此状态的详细信息，请访问[产品生命周期](#)页面。

4 功能方框图

功能方框图 – MSP430F6659、MSP430F6658 展示了 MSP430F6659 和 MSP430F6658 MCU 的功能方框图。



功能方框图 – MSP430F6659、MSP430F6658

图 4-1 展示了 MSP430F6459 和 MSP430F6458 MCU 的功能方框图

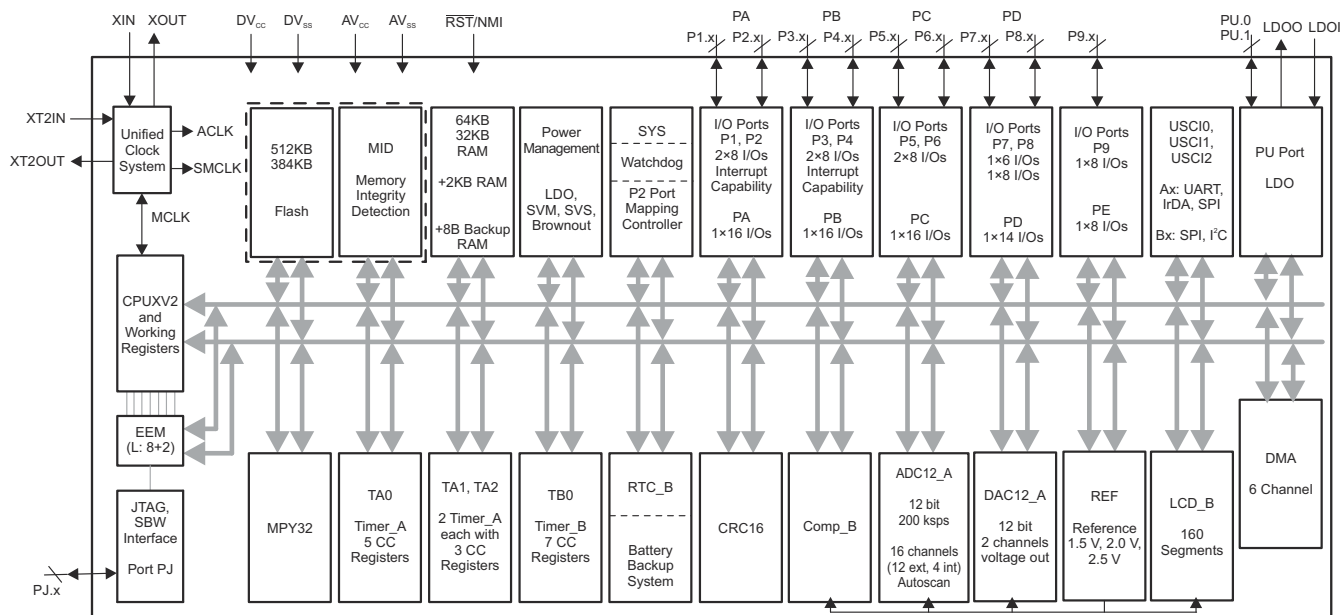


图 4-1. 功能方框图 - MSP430F6459、MSP430F6458

图 4-2 展示了 MSP430F5659 和 MSP430F5658 MCU 的功能方框图。

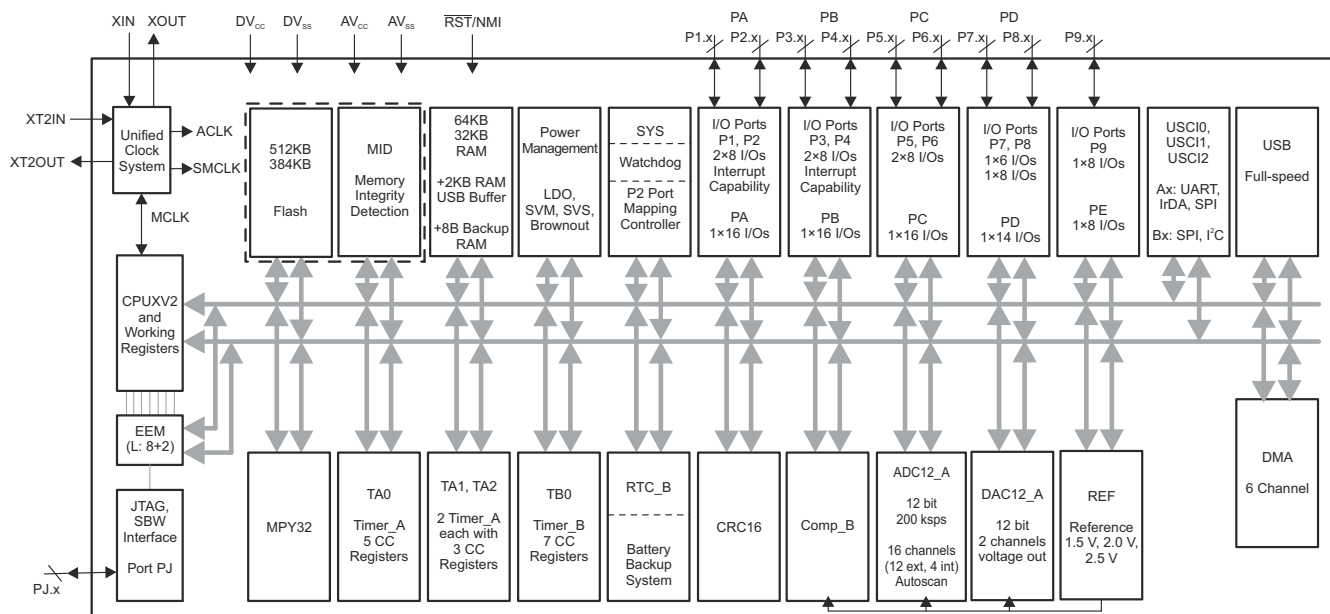


图 4-3 展示了 MSP430F5359 和 MSP430F5358 MCU 的功能方框图。

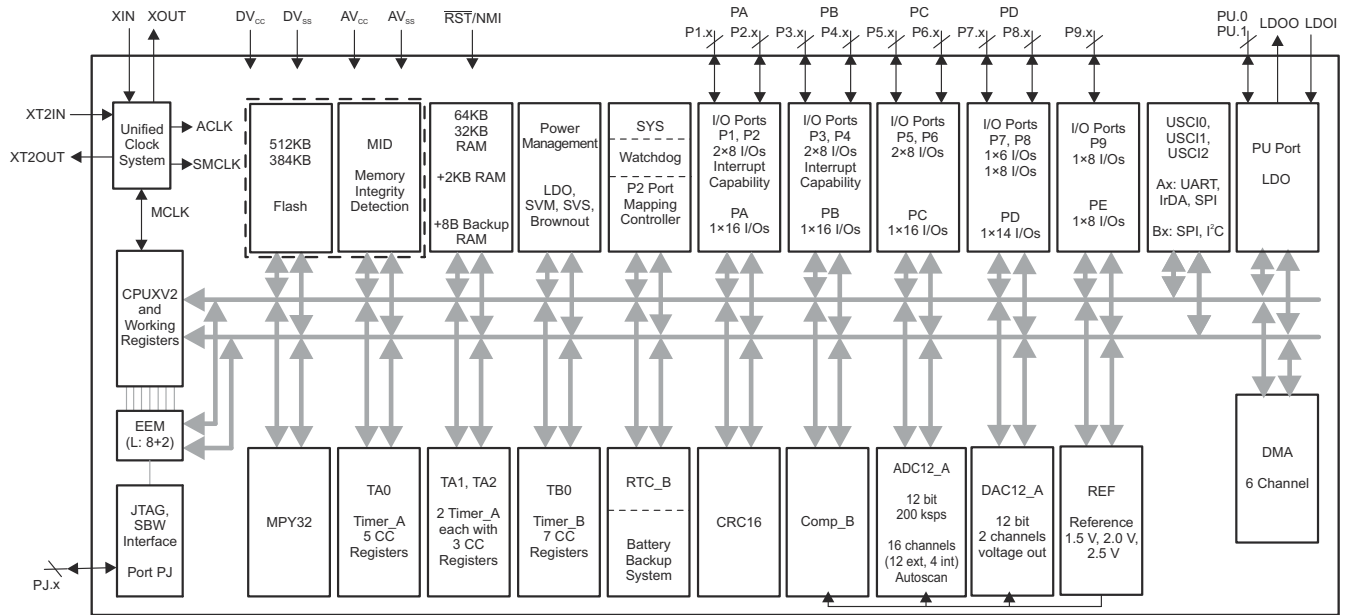


图 4-3. 功能方框图 – MSP430F5359、MSP430F5358

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5 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changed from revision D to revision E

Changes from September 27, 2018 to September 11, 2020	Page
• 更新了整个文档中的章节、表格、图和交叉参考的编号.....	1
• 通篇增加了 nFBGA 封装 (ZCA) 信息.....	1
• 在 器件信息 中添加了有关采用 ZQW 封装的所有可订购器件型号状态变化的注意事项.....	1
• Removed package options that are no longer available (MSP430F6658 and MSP430F6458 in the ZQW package) in 表 6-1, Device Comparison	9
• Removed package options that are no longer available (MSP430F6658IZQW and MSP430F6458IZQW) from the caption of 图 7-5, 113-Pin ZQW Package (Top View) – MSP430F6659IZQW, MSP430F6459IZQW, MSP430F5659IZQW, MSP430F5658IZQW, MSP430F5359IZQW, MSP430F5358IZQW	11
• Changed the MAX value of the I _{ERASE} and I _{MERASE} , I _{BANK} parameters in 节 8.57, Flash Memory	59
• Corrected the connection of the P7SEL.x signal in 图 9-11, Port P7 (P7.4 to P7.7) Diagram	109

Changes from

• 节 8.51, <i>Comparator_B</i> : Added second row for the t_{EN_CMP} parameter with Test Conditions of "CBPWRMD = 10" and MAX value of 100 μ s; Removed "CBPWRMD = 10" option in first row of Test Conditions.....	56
• Added note on R_{PUR} in 节 8.55, <i>USB-PWR (USB Power System)</i>	58
• Removed RTC_B from LPM4.5 wake-up options in 节 9.3, <i>Operating Modes</i>	62
• Throughout document, changed "bootstrap loader" to "bootloader".....	66
• Added the paragraph that begins "Using the MSP430 RTC_B Module With Battery Backup Supply describes how to..."	71
• Corrected spelling of NMIIFG in 表 9-12, <i>System Module Interrupt Vector Registers</i>	71
• Corrected register names (added "USB" prefix as required) in 表 9-53, <i>USB Control Registers</i>	79
• Added P7SEL.2 and XT2BYPASS inputs with AND and OR gates in 图 9-10, <i>Port P7 (P7.3) Diagram</i>	108
• Changed P7SEL.3 column from X to 0 for "P7.3 (I/O)" rows in 表 9-63, <i>Port P7 (P7.2 and P7.3) Pin Functions</i>	108
• Updated 表 9-67, <i>Port PU.0, PU.1 Functions</i>	115
• Added 节 9.13.14, <i>Port PU.0, PU.1 Ports (F645x, F535x)</i>	117
• Added 节 10, <i>Device and Documentation Support</i> , and moved <i>Development Tools Support</i> , <i>Device and Development Tool Nomenclature</i> , <i>Trademarks</i> , and <i>Electrostatic Discharge Caution</i> sections to it.....	121
• Replaced former section	

6 Device Comparison

表 6-1 summarizes the available family members.

表 6-1. Device Comparison

DEVICE ⁽¹⁾	FLASH (KB) ⁽²⁾	SRAM (KB) ⁽⁵⁾	Timer_A ⁽³⁾	Timer_B ⁽⁴⁾	USCI : UART, IrDA, SPI	USCI :B: SPI, I ² C	ADC12_A (channels)	DAC12_A (channels)	Comp_B (channels)	I/O	USB	LCD	PACKAGE
MSP430F6659	512	64 + 2	5, 3, 3	7	3	3	12 ext, 4 int	2	12	74	Yes	Yes	100 PZ, 113 ZCA, 113 ZQW
MSP430F6658	384	32 + 2	5, 3, 3	7	3	3	12 ext, 4 int	2	12	74	Yes	Yes	100 PZ
MSP430F6459	512	66	5, 3, 3	7	3	3	12 ext, 4 int	2	12	74	No	Yes	100 PZ, 113 ZCA, 113 ZQW
MSP430F6458	384	34	5, 3, 3	7	3	3	12 ext, 4 int	2	12	74	No	Yes	100 PZ

6.1 Related Products

For information about other devices in this family of products or related products, see the following links.

[16-bit and 32-bit microcontrollers](#)

High-performance, low-power solutions to enable the autonomous future

[Products for MSP430 ultra-low-power sensing & measurement MCUs](#)

One platform. One ecosystem. Endless possibilities.

[Companion products for MSP430F6659](#)

Review products that are frequently purchased or used with this product.

[TI reference designs](#)

Find reference designs leveraging the best in TI technology to solve your system-level challenges

7 Terminal Configuration and Functions

7.1 Pin Diagrams

图 7-1 shows the pinout of the 100-pin PZ package for the MSP430F6659 and MSP430F6658 devices.

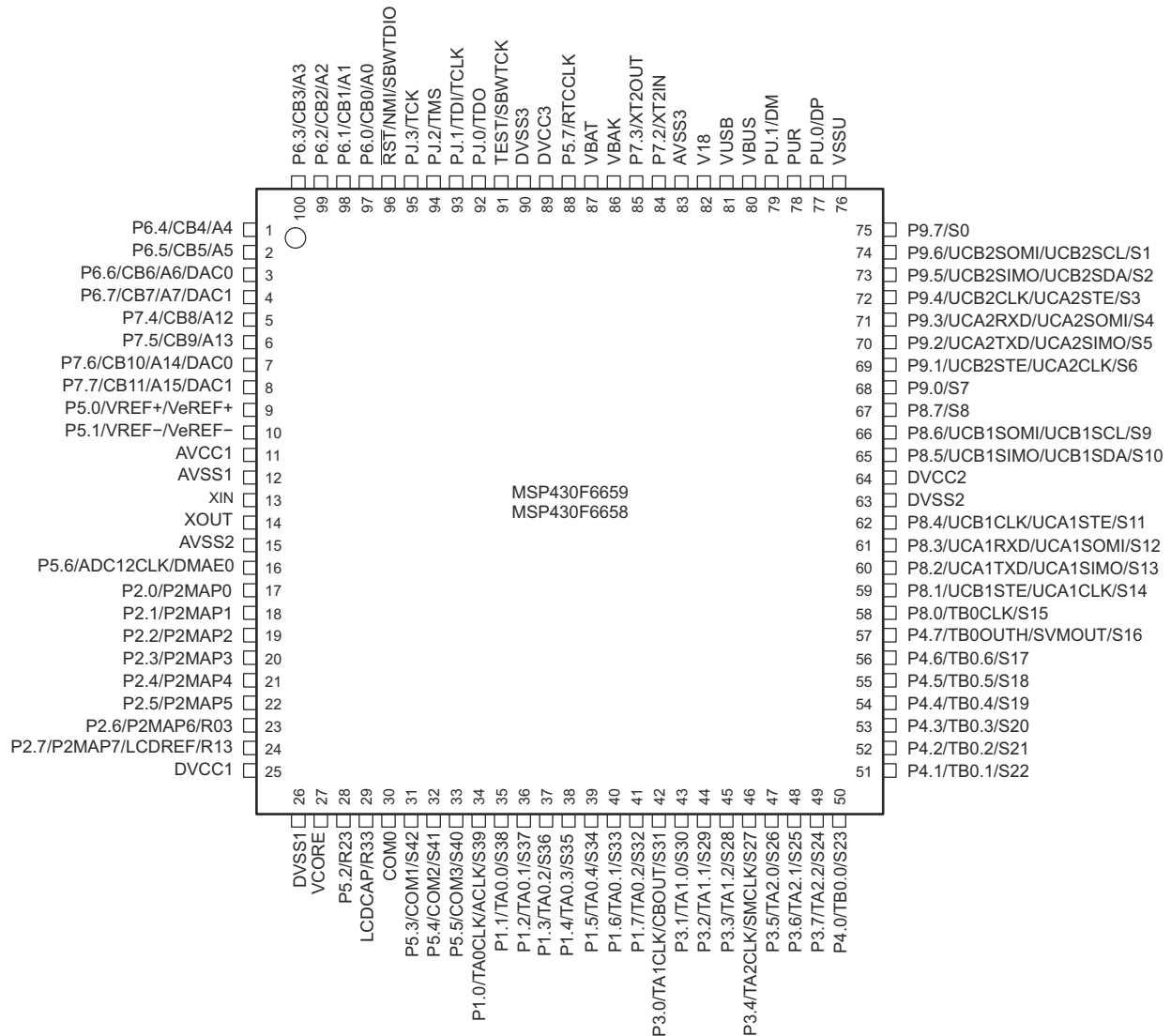


图 7-1 shows the pinout of the 100-pin PZ package for the MSP430F6459 and MSP430F6458 devices.

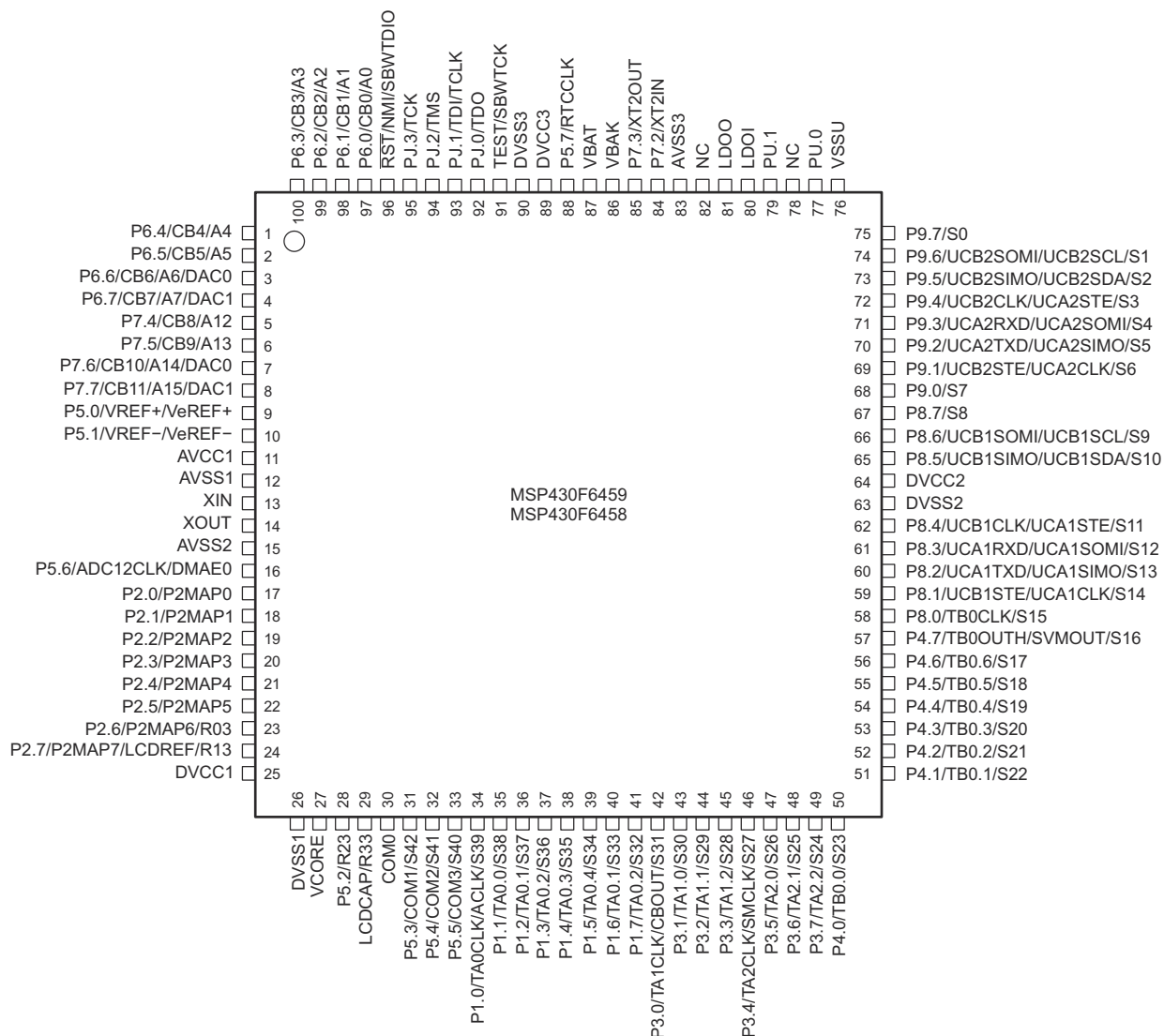


图 7-3 shows the pinout of the 100-pin PZ package for the MSP430F5659 and MSP430F5658 devices.

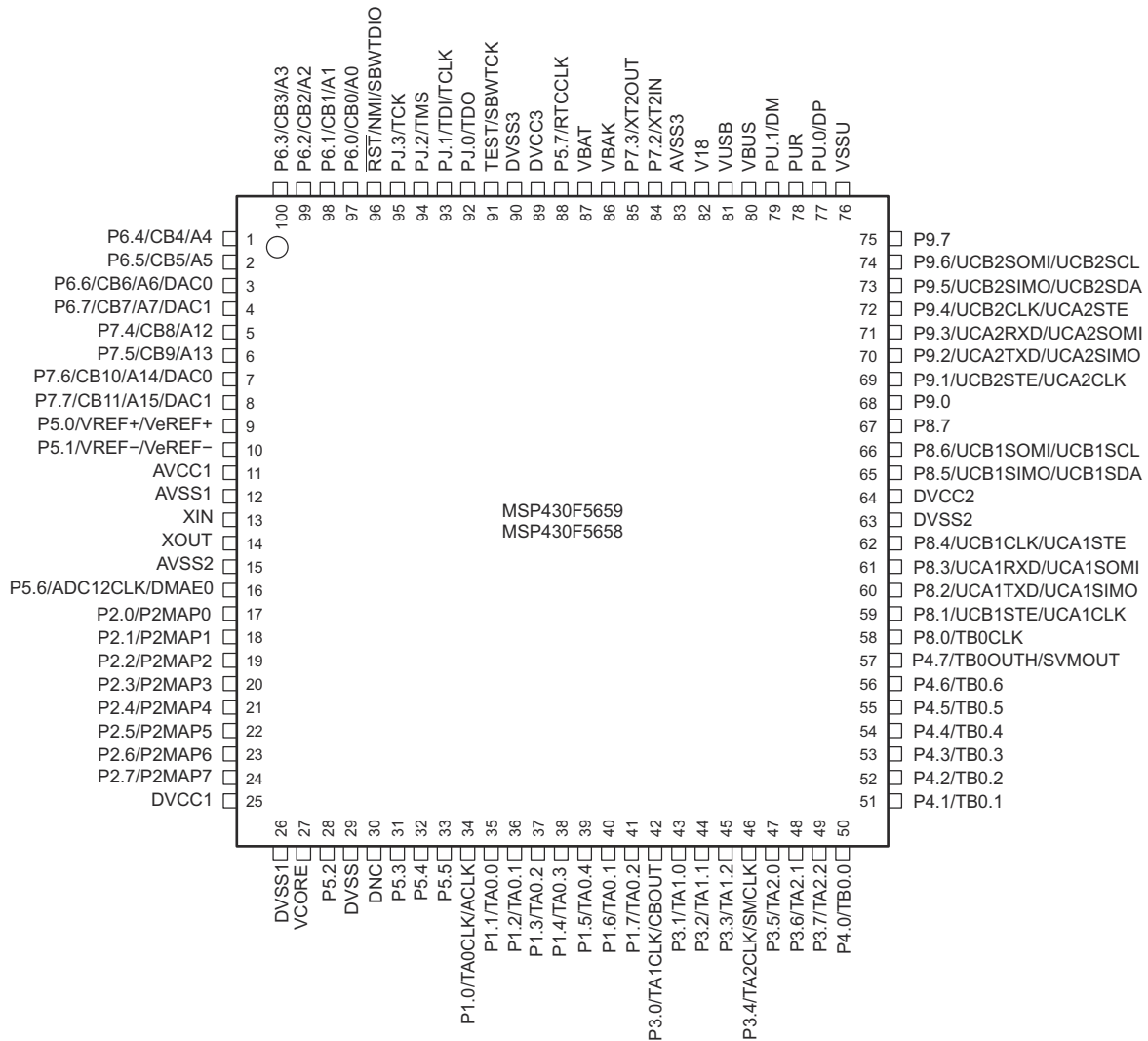


Figure 7-4 shows the pinout of the 100-pin PZ package for the MSP430F5359 and MSP430F5358 devices.

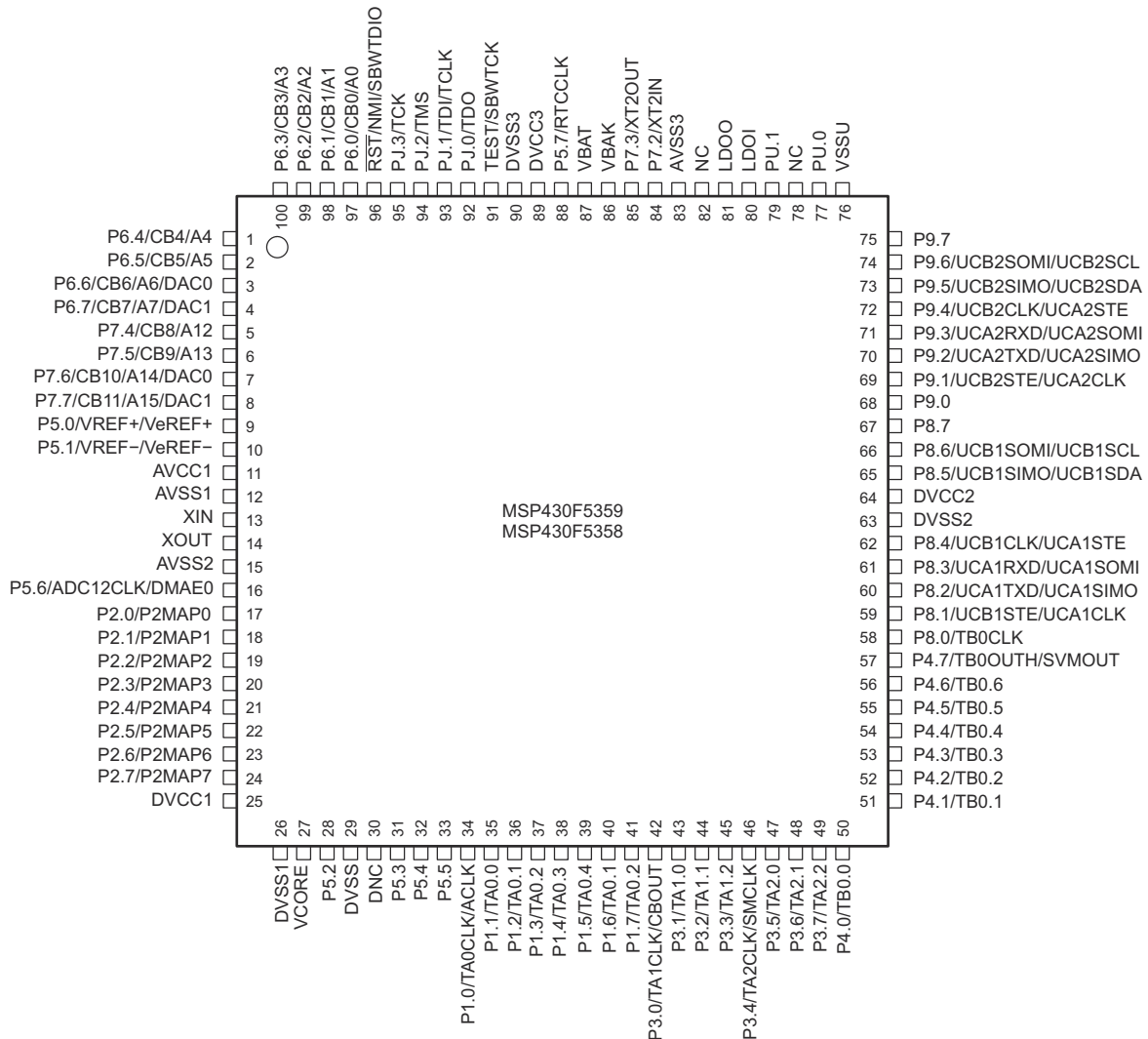


图 7-4 shows the pinout of the 113-pin ZCA or ZQW package. See 节 7.2 for the pin assignments.

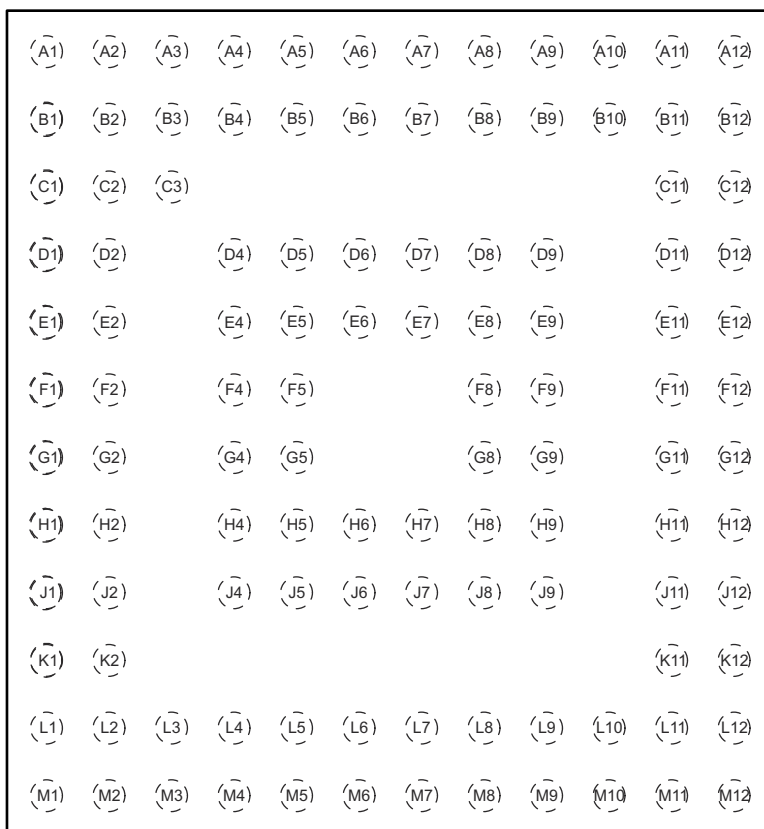


图 7-5. 113-Pin ZCA or ZQW Package (Top View) – MSP430F6659IZCA, MSP430F6459IZCA, MSP430F5659IZCA, MSP430F5658IZCA, MSP430F5359IZCA, MSP430F5358IZCA, MSP430F6659IZQW, MSP430F6459IZQW, MSP430F5659IZQW, MSP430F5658IZQW, MSP430F5359IZQW, MSP430F5358IZQW

7.2 Signal Descriptions

表 7-1 describes the signals for all device variants and package options.

表 7-1. Signal Descriptions

TERMINAL			I/O ⁽¹⁾	DESCRIPTION
NAME	NO.			
	PZ	ZCA, ZQW		
P6.4/CB4/A4	1	A1	I/O	General-purpose digital I/O Comparator_B input CB4 Analog input A4 for ADC
P6.5/CB5/A5	2	B2	I/O	General-purpose digital I/O Comparator_B input CB5 Analog input A5 for ADC
P6.6/CB6/A6/DAC0	3	B1	I/O	General-purpose digital I/O Comparator_B input CB6 Analog input A6 for ADC DAC12.0 output
P6.7/CB7/A7/DAC1	4	C2	I/O	General-purpose digital I/O Comparator_B input CB7 Analog input A7 for ADC DAC12.1 output
P7.4/CB8/A12	5	C1	I/O	General-purpose digital I/O Comparator_B input CB8 Analog input A12 for ADC
P7.5/CB9/A13	6	C3	I/O	General-purpose digital I/O Comparator_B input CB9 Analog input A13 for ADC
P7.6/CB10/A14/DAC0	7	D2	I/O	General-purpose digital I/O Comparator_B input CB10 Analog input A1

表 7-1. Signal Descriptions (continued)

TERMINAL		NO.	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ			
P2.0/P2MAP0	17	G4	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_B0 SPI slave transmit enable; USCI_A0 clock input/output
P2.1/P2MAP1	18	H2	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_B0 SPI slave in, master out; USCI_B0 I2C data
P2.2/P2MAP2	19	J1	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_B0 SPI slave out, master in; USCI_B0 I2C clock
P2.3/P2MAP3	20	H4	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_B0 clock input/output; USCI_A0 SPI slave transmit enable
P2.4/P2MAP4	21	J2	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_A0 UART transmit data; USCI_A0 SPI slave in, master out
P2.5/P2MAP5	22	K1	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_A0 UART receive data; USCI_A0 slave out, master in
P2.6/P2MAP6/R03	23	K2	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: no secondary function Input/output port of lowest analog LCD voltage (V5) (not available on F5659, F5658, F5359, F5358 devices)
P2.7/P2MAP7/LCDREF/R1				

表 7-1. Signal Descriptions (continued)

TERMINAL		NO.	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ			
P5.5/COM3/S40	33	J5	I/O	General-purpose digital I/O LCD common output COM3 for LCD backplane (not available on F5659, F5658, F5359, F5358 devices) LCD segment output S40 (not available on F5659, F5658, F5359, F5358 devices)
P1.0/TA0CLK/ACLK/S39	34	L5	I/O	General-purpose digital I/O with port interrupt Timer TA0 clock signal TACLK input ACLK output (divided by 1, 2, 4, 8, 16, or 32) LCD segment output S39 (not available on F5659, F5658, F5359, F5358 devices)
P1.1/TA0.0/S38	35	M5	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR0 capture: CCI0A input, compare: Out0 output BSL transmit output LCD segment output S38 (not available on F5659, F5658, F5359, F5358 devices)
P1.2/TA0.1/S37	36	J6	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR1 capture: CCI1A input, compare: Out1 output BSL receive input LCD segment output S37 (not available on F5659, F5658, F5359, F5358 devices)
P1.3/TA0.2/S36	37	H6	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR2 capture: CCI2A input, compare: Out2 output LCD segment output S36 (not available on F5659, F5658, F5359, F5358 devices)
P				

表 7-1. Signal Descriptions (continued)

TERMINAL		NO.	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ			
P3.4/TA2CLK/SMCLK/S27	46	J8	I/O	General-purpose digital I/O with port interrupt Timer TA2 clock input SMCLK output LCD segment output S27 (not available on F5659, F5658, F5359, F5358 devices)
P3.5/TA2.0/S26	47	M9	I/O	General-purpose digital I/O with port interrupt Timer TA2 capture CCR0: CCI0A/CCI0B input, compare: Out0 output LCD segment output S26 (not available on F5659, F5658, F5359, F5358 devices)
P3.6/TA2.1/S25	48	L9	I/O	General-purpose digital I/O with port interrupt Timer TA2 capture CCR1: CCI1A/CCI1B input, compare: Out1 output LCD segment output S25 (not available on F5659, F5658, F5359, F5358 devices)
P3.7/TA2.2/S24	49	M10	I/O	General-purpose digital I/O with port interrupt Timer TA2 capture CCR2: CCI2A/CCI2B input, compare: Out2 output LCD segment output S24 (not available on F5659, F5658, F5359, F5358 devices)
P4.0/TB0.0/S23	50	J9	I/O	General-purpose digital I/O with port interrupt Timer TB0 capture CCR0: CCI0A/CCI0B input, compare: Out0 output LCD segment output S23 (not available on F5659, F5658, F5359, F5358 devices)
P4.1/TB0.1/S22				

表 7-1. Signal Descriptions (continued)

TERMINAL		NO.	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ			
P8.2/UCA1TXD/UCA1SIMO/S13	60	H11	I/O	General-purpose digital I/O USCI_A1 UART transmit data USCI_A1 SPI slave in, master out LCD segment output S13 (not available on F5659, F5658, F5359, F5358 devices)
P8.3/UCA1RXD/UCA1SOMI/S12	61	H12	I/O	General-purpose digital I/O USCI_A1 UART receive data USCI_A1 SPI slave out, master in LCD segment output S12 (not available on F5659, F5658, F5359, F5358 devices)
P8.4/UCB1CLK/UCA1STE/S11	62	G11	I/O	General-purpose digital I/O USCI_B1 clock input/output USCI_A1 SPI slave transmit enable LCD segment output S11 (not available on F5659, F5658, F5359, F5358 devices)
DVSS2	63	G12		Digital ground supply
DVCC2	64	F12		Digital power supply
P8.5/UCB1SIMO/UCB1SDA/S10	65	F11	I/O	General-purpose digital I/O USCI_B1 SPI slave in, master out USCI_B1 I2C data LCD segment output S10 (not available on F5659, F5658, F5359, F5358 devices)
P8.6/UCB1SOMI/UCB1SCL/S9	66	G9	I/O	General-purpose digital I/O US

表 7-1. Signal Descriptions (continued)

TERMINAL		NO.	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ	ZCA, ZQW		
P9.6/UCB2SOMI/UCB2SCL/S1	74	C11	I/O	General-purpose digital I/O USCI_B2 SPI slave out, master in USCI_B2 I2C clock LCD segment output S1 (not available on F5659, F5658, F5359, F5358 devices)
P9.7/S0	75	D9	I/O	General-purpose digital I/O LCD segment output S0 (not available on F5659, F5658, F5359, F5358 devices)
VSSU	76	B11, B12		USB PHY or PU ground supply
PU.0/DP	77	A12	I/O	General-purpose digital I/O – controlled by USB or PU control register (Port U is supplied the LDOO rail) USB data terminal DP (not available on F6459, F6458, F5359, F5358 devices)
PUR	78	B10	I/O	USB pullup resistor pin (open drain) (not available on F6459, F6458, F5359, F5358 devices)
NC	78	B10		Not connected (not available on F6659, F6658, F5659, F5658 devices)
PU.1/DM	79	A11	I/O	General-purpose digital I/O – controlled by USB or PU control register (Port U is supplied the LDOO rail) USB data terminal DM (not available on F6459, F6458, F5359, F5358 devices)
VB				

表 7-1. Signal Descriptions (continued)

TERMINAL		NO.	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ			
PJ.3/TCK	95	D6	I/O	General-purpose digital I/O Test clock
RST/NMI/SBWDIO	96	A3	I/O	Reset input active low ⁽³⁾ Nonmaskable interrupt input Spy-Bi-Wire data input/output
P6.0/CB0/A0	97	B4	I/O	General-purpose digital I/O Comparator_B input CB0 Analog input A0 for ADC
P6.1/CB1/A1	98	B3	I/O	General-purpose digital I/O Comparator_B input CB1 Analog input A1 for ADC
P6.2/CB2/A2	99	A2	I/O	General-purpose digital I/O Comparator_B input CB2 Analog input A2 for ADC
P6.3/CB3/A3	100	D5	I/O	General-purpose digital I/O Comparator_B input CB3 Analog input A3 for ADC
Reserved	N/A	E5, E6, E8, F4, F5, F8, G5, G8, H5, H8, H9		Reserved BGA package balls. TI recommends connecting to ground (DVSS, AVSS).

(1) I = input, O = output, N/A = not available on this package offering

(2) V_{CORE} is for internal use only. No external current loading is possible. V_{CORE} should only be connected

8 Specifications

All graphs in this section are for typical conditions, unless otherwise noted.

Typical (TYP) values are specified at $V_{CC} = 3.3\text{ V}$ and $T_A = 25^\circ\text{C}$, unless otherwise noted.

8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

	MIN	MAX	UNIT
Voltage applied at V_{CC} to V_{SS}	- 0.3	4.1	V
Voltage applied to any pin (excluding V_{CORE} , V_{BUS} , V_{18}) ⁽²⁾	- 0.3	$V_{CC} + 0.3$	V
Diode current at any device pin		± 2	mA
Storage temperature, T_{stg} ⁽³⁾	- 55	150	$^\circ\text{C}$
Maximum junction temperature, T_J		95	$^\circ\text{C}$

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages referenced to V_{SS} . V_{CORE}

		MIN	NOM	MAX	UNIT
$C_{DVCC}/C_{V_{CORE}}$	Capacitor ratio of DVCC to V _{CORE}	10			
f_{SYSTEM}	Processor frequency (maximum MCLK frequency) ⁽⁴⁾ ⁽⁵⁾ (see 图 8-1)	PMMCOREVx = 0, 1.8 V ≤ V _{CC} ≤ 3.6 V (default condition)		0	8.0
		PMMCOREVx = 1, 2 V ≤ V _{CC} ≤ 3.6 V		0	12.0
		PMMCOREVx = 2, 2.2 V ≤ V _{CC} ≤ 3.6 V		0	16.0
		PMMCOREVx = 3, 2.4 V ≤ V _{CC} ≤ 3.6 V		0	20.0
f_{SYSTEM_USB}	Minimum processor frequency for USB operation	1.5			MHz
USB_wait	Wait state cycles during USB operation		16		cycles

- (1) TI recommends powering AVCC and DVCC from the same source. A maximum difference of 0.3 V between AVCC and DVCC can be tolerated during power up and operation.
- (2) The minimum supply voltage is defined by the supervisor SVS levels when it is enabled. See the 节 8.23 threshold parameters for the exact values and further details.
- (3) A capacitor tolerance of ±2

8.4 Active Mode Supply Current Into V_{CC} Excluding External Current

over recommended operating free-air temperature (unless otherwise noted)^{(1) (2) (3)}

PARAMETER	EXECUTION MEMORY	V_{CC}	PMMCOREVx	FREQUENCY ($f_{DCO} = f_{MCLK} = f_{SMCLK}$)								UNIT	
				1 MHz		8 MHz		12 MHz		20 MHz			
				TYP	MAX	TYP	MAX	TYP	MAX	TYP	MAX		
$I_{AM, Flash}$	Flash	3 V	0	0.36	0.45	2.4	2.7					mA	
			1	0.41		2.7		4.0	4.4				

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)^{(1) (2)}

PARAMETER	V _{CC}	PMMCOREV _x	- 40°C		25°C		60°C		85°C		UNIT
			TYP	MAX	TYP	MAX	TYP	MAX	TYP	MAX	
I _{LPM3.5,RTC,VBAT}	Low-power mode 3.5 (LPM3.5) current with active RTC into backup supply pin VBAT ⁽¹¹⁾	3 V			0.6				0.75	1.0	μA
I _{LPM3.5,RTC,TOT}	Total low-power mode 3.5 (LPM3.5) current with active RTC ⁽¹²⁾	3 V	1.0		1.1		1.2		1.5	2.8	μA
I _{LPM4.5}	Low-power mode 4.5 ⁽⁸⁾	3 V	0.4		0.45	0.6	0.5		0.76	1.8	μA

- (1) All inputs are tied to 0 V or to V_{CC}. Outputs do

8.6 Low-Power Mode With LCD Supply Currents (Into V_{CC}) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)^{(1) (2)}

PARAMETER	V_{CC}	PMMCOREVx	TEMPERATURE (T_A)								UNIT	
			- 40°C		25°C		60°C		85°C			
			TYP	MAX	TYP	MAX	TYP	MAX	TYP	MAX		
$I_{LPM3\ LCD, \text{ int. bias}}$ Low-power mode 3 (LPM3) current, LCD 4-mux mode, internal biasing, charge pump disabled ^{(1) (2)}	3 V	0	2.7		3.3	4.8	4.7		9.5	28	μA	
		1	2.9		3.5		5.0		9.9			

8.8 Schmitt-Trigger Inputs – General-Purpose I/O

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER ⁽¹⁾	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
V _{IT+} Positive-going input threshold voltage		1.8 V	0.80		1.40	V
		3 V	1.50		2.10	
V _{IT-} Negative-going input threshold voltage		1.8 V	0.45		1.00	V
		3 V	0.75		1.65	
V _{hys} Input voltage hysteresis (V _{IT+} – V _{IT-})		1.8 V	0.3		0.8	V
		3 V	0.4		1.0	
R _{Pull} Pullup or pulldown resistor ⁽²⁾	For pullup: V _{IN} = V _{SS} For pulldown: V _{IN} = V _{CC}		20	35	50	kΩ
C _I Input capacitance	V _{IN} = V _{SS} or V _{CC}			5		pF

8.12 Outputs – General-Purpose I/O (Reduced Drive Strength)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽³⁾

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
V _{OH} High-level output voltage	I _(OHmax) = - 1 mA ⁽¹⁾	1.8 V	V _{CC} - 0.25	V _{CC}	V
	I _(OHmax) = - 3 mA ⁽²⁾		V _{CC} - 0.60	V _{CC}	
	I _(OHmax) = - 2 mA ⁽¹⁾	3 V	V _{CC} - 0.25	V _{CC}	
	I _(OHmax) = - 6 mA ⁽²⁾		V _{CC} - 0.60	V _{CC}	
V _{OL} Low-level output voltage	I _(OLmax) = 1 mA ⁽¹⁾	1.8 V	V _{SS}	V _{SS} + 0.25	V
	I _(OLmax) = 3 mA ⁽²⁾		V _{SS}	V _{SS} + 0.60	
	I _(OLmax) = 2 mA ⁽¹⁾				

8.14 Typical Characteristics – Outputs, Reduced Drive Strength (PxDS.y = 0)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

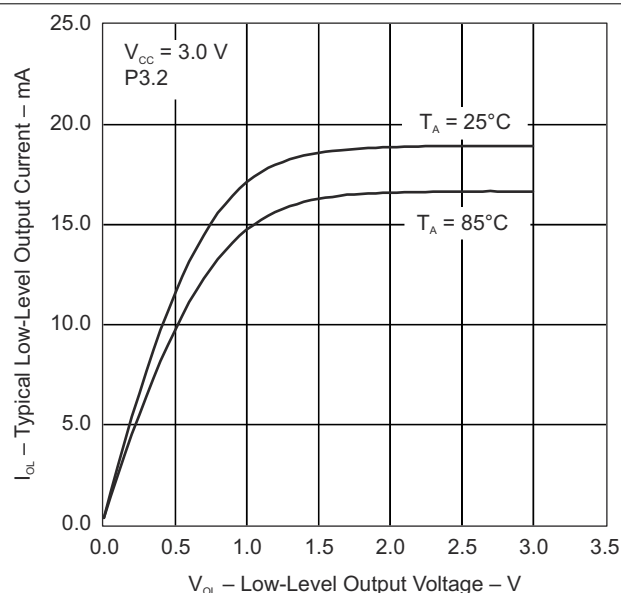


图 8-2. Typical Low-Level Output Current vs Low-Level Output Voltage

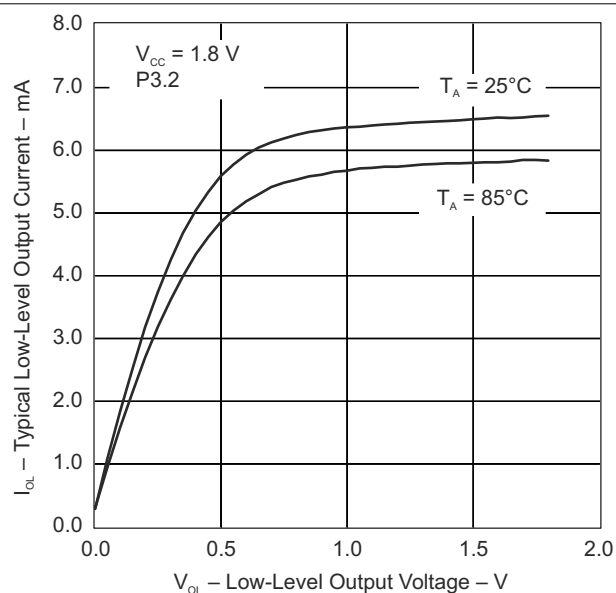
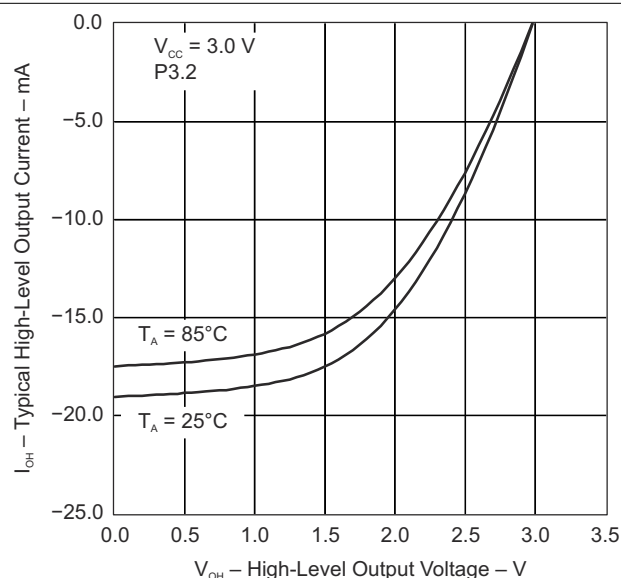


图 8-3. Typical Low-Level Output Current vs Low-Level Output Voltage



8.15 Typical Characteristics – Outputs, Full Drive Strength (PxDS.y = 1)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

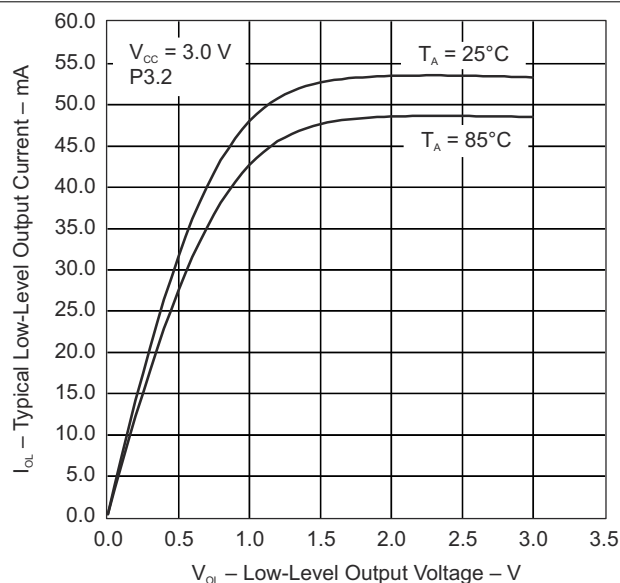


图 8-6. Typical Low-Level Output Current vs Low-Level Output Voltage

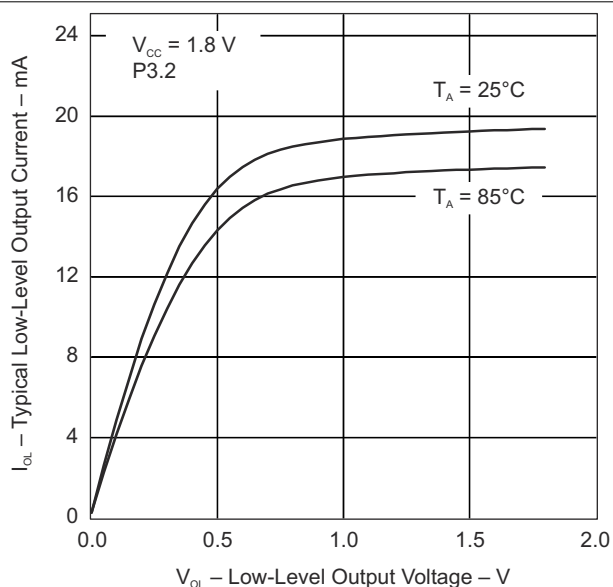


图 8-7. Typical Low-Level Output Current vs Low-Level Output Voltage

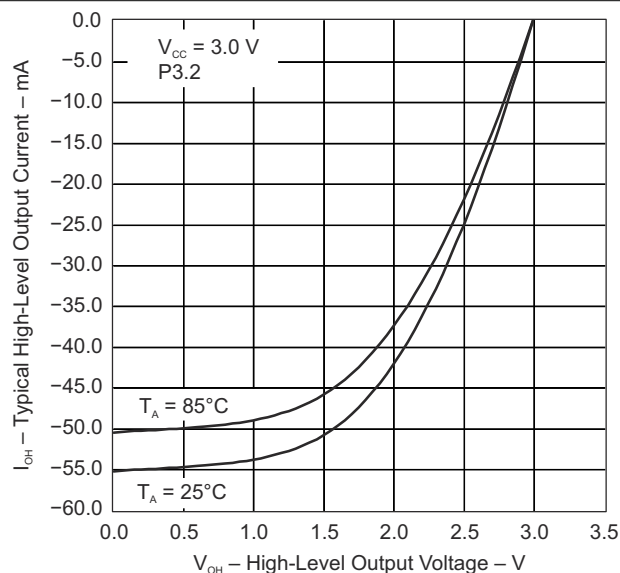


图 8-8.

8.16 Crystal Oscillator, XT1, Low-Frequency Mode

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER ⁽⁵⁾	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
$\Delta I_{DVCC,LF}$ Differential XT1 oscillator crystal current consumption from lowest drive setting, LF mode	$f_{OSC} = 32768$ Hz, XTS = 0, XT1BYPASS = 0, XT1DRIVE _x = 1, T _A = 25°C	3 V	0.075		μ A	
	$f_{OSC} = 32768$ Hz, XTS = 0, XT1BYPASS = 0, XT1DRIVE _x = 2, T _A = 25°C		0.170			
	$f_{OSC} = 32768$ Hz, XTS = 0, XT1BYPASS = 0, XT1DRIVE _x = 3, T _A = 25°C		0.290			
$f_{XT1,LF0}$ XT1 oscillator crystal frequency, LF mode	XTS = 0, XT1BYPASS = 0		32768		Hz	
$f_{XT1,LF,SW}$ XT1 oscillator logic-level square-wave input frequency, LF mode	XTS = 0, XT1BYPASS = 1 ^{(6) (7)}		10	32.768		

8.17 Crystal Oscillator, XT2

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)^{(2) (5)}

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
I _{DVCC,XT2} XT2 oscillator crystal current consumption	f _{OSC} = 4 MHz, XT2OFF = 0, XT2BYPASS = 0, XT2DRIVE _x = 0, T _A = 25°C	3 V		200		μA
	f _{OSC} = 12 MHz, XT2OFF = 0, XT2BYPASS = 0, XT2DRIVE _x = 1, T _A = 25°C			260		
	f _{OSC} = 20 MHz, XT2OFF = 0, XT2BYPASS = 0, XT2DRIVE _x = 2, T _A = 25°C			325		
	f _{OSC} = 32 MHz, XT2OFF = 0, XT2BYPASS = 0, XT2DRIVE _x = 3, T _A = 25°C			450		
f _{XT2,HF0} XT2 oscillator crystal frequency, mode 0	XT2DRIVE _x = 0, XT2BYPASS = 0 ⁽⁷⁾		4		8	MHz
f _{XT2,HF1} XT2 oscillator crystal frequency, mode 1	XT2DR					

8.18 Internal Very-Low-Power Low-Frequency Oscillator (VLO)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT	
f _{VLO}	VLO frequency	Measured at ACLK	1.8 V to 3.6 V	6	9.4	14	kHz
df _{VLO} /dT	VLO frequency temperature drift	Measured at ACLK ⁽¹⁾	1.8 V to 3.6 V	0.5			%/°C
df _{VLO} /dV _{CC}	VLO frequency supply voltage drift	Measured at ACLK ⁽²⁾	1.8 V to 3.6 V	4			%/V
	Duty cycle	Measured at ACLK	1.8 V to 3.6 V	40%	50%	60%	

(1) Calculated using the box method: (MAX(- 40°C to 85°C) - MIN(- 40°C to 85°C)) / MIN(- 40°C to 85°C) / (85°C - (- 40°C))

(2) Calculated using the box method: (MAX(1.8 V to 3.6 V) - MIN(1.8 V to 3.6 V)) / MIN(1.8 V to 3.6 V) / (3.6 V - 1.8 V)

8.19 Internal Reference, Low-Frequency Oscillator (REFO)

8.20 DCO Frequency

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f_{\text{DCO}(0,0)}$ DCO frequency (0, 0) ⁽¹⁾	DCORSELx = 0, DCOx = 0, MODx = 0	0.07		0.20	MHz
$f_{\text{DCO}(0,31)}$ DCO frequency (0, 31) ⁽¹⁾	DCORSELx = 0, DCOx = 31, MODx = 0	0.70		1.70	MHz
$f_{\text{DCO}(1,0)}$ DCO frequency (1, 0) ⁽¹⁾	DCORSELx = 1, DCOx = 0, MODx = 0	0.15		0.36	MHz
$f_{\text{DCO}(1,31)}$ DCO frequency (1, 31) ⁽¹⁾	DCORSELx = 1, DCOx = 31, MODx = 0	1.47		3.45	MHz
$f_{\text{DCO}(2,0)}$ DCO frequency (2, 0) ⁽¹⁾	DCORSELx = 2, DCOx = 0, MODx = 0	0.32		0.75	MHz
$f_{\text{DCO}(2,31)}$ DCO frequency (2, 31) ⁽¹⁾	DCORSELx = 2, DCOx = 31, MODx = 0	3.17		7.38	MHz
$f_{\text{DCO}(3,0)}$ DCO frequency (3, 0) ⁽¹⁾	DCORSELx = 3, DCOx = 0, MODx = 0	0.64		1.51	MHz
$f_{\text{DCO}(3,3$					

8.21 PMM, Brownout Reset (BOR)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{(DVCC_BOR_IT-)}$	BOR _H on voltage, DV _{CC} falling level	$ dDV_{CC}/dt < 3 \text{ V/s}$			1.45	V
$V_{(DVCC_BOR_IT+)}$	BOR _H off voltage, DV _{CC} rising level	$ dDV_{CC}/dt < 3 \text{ V/s}$	0.80	1.30	1.50	V
$V_{(DVCC_BOR_hys)}$	BOR _H hysteresis		50		250	mV
t_{RESET}	Pulse duration required at RST/NMI pin to accept a reset		2			μs

8.22 PMM, Core Voltage

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{CORE3(AM)}$	Core voltage, active mode, PMMCOREV = 3					

8.23 PMM, SVS High Side

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{(SVSH)}$ SVS current consumption	SVSHE = 0, $DV_{CC} = 3.6\text{ V}$		0		nA
	SVSHE = 1, $DV_{CC} = 3.6\text{ V}$, SVSHFP = 0		200		
	SVSHE = 1, $DV_{CC} = 3.6\text{ V}$, SVSHFP = 1		2.0		μA
$V_{(SVSH_IT-)}$ SVS _H on voltage level ⁽¹⁾	SVSHE = 1, SVSHRVL = 0	1.59	1.64	1.69	V
	SVSHE = 1, SVSHRVL = 1	1.79	1.84	1.91	
	SVSHE = 1, SVSHRVL = 2	1.98	2.04	2.11	
	SVSHE = 1, SVSHRVL = 3	2.10	2.16	2.23	
$V_{(SVSH_IT+)}$ SVS _H off voltage level ⁽¹⁾	SVSHE = 1, SVSMH				

8.25 PMM, SVS Low Side

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{(SVSL)}$ SVS _L current consumption	SVSLE = 0, PMMCOREV = 2		0		nA
	SVSLE = 1, PMMCOREV = 2, SVSLFP = 0		200		
	SVSLE = 1, PMMCOREV = 2, SVSLFP = 1		2.0		μA
$t_{pd(SVSL)}$ SVS _L propagation delay</					

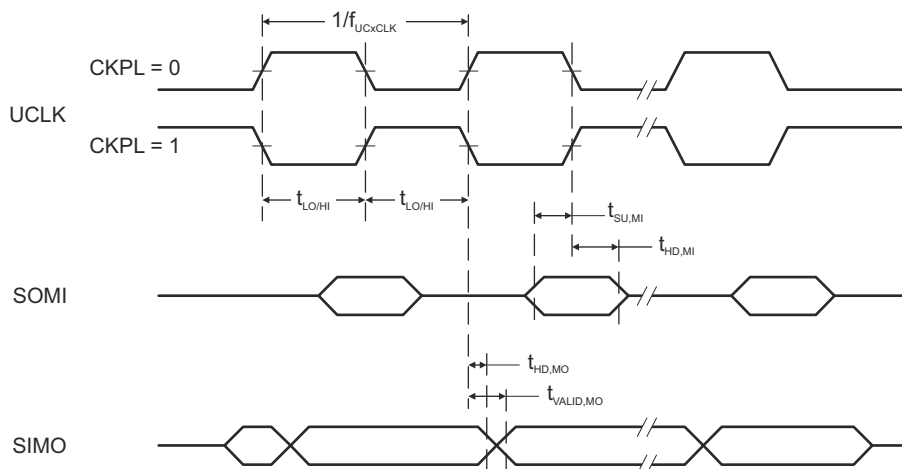


图 8-11. SPI Master Mode, CKPH = 0

